

Search Notes**Application/Control No.**

10/622,164

Examiner

Leda T. Pham

Applicant(s)/Patent under Reexamination

SAKAI ET AL.

Art Unit

2834

SEARCHED

Class	Subclass	Date	Examiner
310	239	3/11/2005	LP
310	71	3/11/2005	LP
310	242	3/11/2005	LP
310	248	3/11/2005	LP
310	249	3/11/2005	LP
310	89	3/11/2005	LP
310	40MM	3/11/2005	LP
310	68C	3/11/2005	LP

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
H02k011\$.ipc and brushes	3/11/2005	LP

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner